

Search Notes**Application/Control No.**

09/835,821

Examiner

Mark A. Mais

Applicant(s)/Patent under Reexamination

EIKKULA, JARI

Art Unit

2619

SEARCHED

Class	Subclass	Date	Examiner
370	254 265	2/1/2008	MAM
	270 433		
	443 455		
	463		
709	212 217		
	223		
379	111		
	112.01		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Wellington Chin	9/20/2005	MAM
See Attached Electronic Search	9/20/2005	MAM
See Inventorship Search	9/20/2005	MAM
See Non-Patent Literature Search	6/1/2006	MAM
See Attached Electronic Search [updated]	6/26/2006	MAM
See Attached Electronic Search [updated]	2/18/2007	MAM
See Attached Electronic Search [updated]	8/9/2007	MAM
See Attached Electronic Search [updated]	2/1/2008	MAM